

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/694,853	LAUNAIS ET AL.	
Examiner	Art Unit	_
M. Alexandra Elve	1725	

	SEAR	CHED	
Class	Subclass	Date	Examiner
update		~	
219	121.64	2/6/2006	MAE
219	121.85	2/6/2006	MAE
219	121.63	2/6/2006	MAE
219	121.6	2/6/2002	MAE

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
219	121.64	2/6/2006	MAE		
219	121.85	2/6/2006	MAE		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
update US OCR, US PAT, US PG, Derwent, JPO, EPO	2/6/2006	MAE			
Interference search (see attached search strategy)	2/6/2006	MAE			
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